

Component Title:

Switching Diodes based on types 1N5819U and 1N5822U

Page 1
Appl. No.

200		E	xecutive Member:	CNE	S			D	ate: 29/06/2018	3	02D
Components (includ	ng series and fami	lies) s	ubmitted for Extension	on of Q	ualification	Approval:					_1_
ESCC COMPONENT NO.	COMPONENT VARIANTS			RANGE OF COMPONENTS			BASED ON		TEST VEHICLE / S	COMPO SIMIL	
5106/021	02, 03		LCC2B	LCC2B 1N5819U				ID33125201XZ			
5106/020	01, 02		LCC2B			1N582	2U		ID33622004ZW		
Component M	anufacturer	2	Location of M	1anufac	cturing Plan	nt(s)	3				4
Component Manufacturer 2 STMicroelectronics			Location of Manufacturing Plant(s) 3 3, rue de Suisse BP4199, 35041 Rennes Cedex				Date of original qualification approval: Date: 01/09/2010 Certificate Ref No. 302				
		5					6				7
ESCC Specifications			Deviations to LVT used:	testing	and Detail	Specificati	ion	Qualification Extension Report reference and date:			
Generic: 5000		6	No ⊠ Yes ☐ (supply details in Box 15)				ID33622004ZW _1N5822U _ChartF4 - 12/02/2018 ID33125201XZ _1N5919U _ChartF4 - 24/01/2017			018	
Detail(s): 5106/021 Issue: 3 5106/020 3			Deviation from current Specifications: No ⊠ Yes □ (Supply details)								
											8
Summary of procure	ment or equivalent	test r	esults during current	validity	period in s	support of t	his ap	plicatio	on (those to ESCC listed	first)	
Project Name	Testing L	evel	LAT			Date code	9		Quanti	ty Delivered	
See appendix											
PID changes since s	tart of qualification		9	Cu	ırrent PID	Verified by	/ :		CNES		10
None								N	lame of Excutive Repres	sentative	
Minor* ⊠				Re	ef No:	8097046	(gene	ric) Rev	v18 and 8170379 (specif	fic Diodes switchi	ng) rev17
Major* □	Issue: Rev Date:				Date	e: 15/07/20)16				
	Marie San		9,000						~		11
Current Manufacturi	ed by:		me of F	CNES Executive R	enresenta	tive)	or	ո 2	(Date)		
Satisfactory:	Yes 🗵			explain		оргозепіа	uvej			(Date)	
Report Reference:	CR-ST-27	7-03-2	018								

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Page 2 Switching Diodes based on types 1N5819U and 1N5822U Component title: Appl. No. Executive Member: CNES 29/06/2018 Date: 302D 12 Failure Analysis, DPA, NCCS available: Yes No \boxtimes (Supply data) Ref. No's and purposes: 13 The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; - that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein. 25/07/2018 Date: JP. BUSSENOT (Signature of the Executive Coordinator) Continuation of Boxes above: 14

Component title:

Executive Member:

CNES

Switching Diodes based on types 1N5819U and 1N5822U

Date: 29/06/2018

Page 3 Appl. No.

302D

Non comp	liance to ESCC requirements:			15
No.:	Specification	Paragraph	Non compliance	
i i				
Additional noncompli	tasks required to achieve full compliance for	ESCC qualification or rationale for acceptability	of	16
1,0,100,11,p.i.				
Executive	Manager Disposition			17
	Approval: Yes 🗡 No 🗆			
Action / Re	emarks:			
			10	
			3. 81	
Date:			" "	
			B. Schade, Head of Product Assurance And Safety Department - ESA Representative	



Component Title:

Switching Diodes based on types 1N5819U and 1N5822U

0/00/0040

Appl. No.

18

Page 4

Executive Member:

CNES

Date: 29/06/2018

ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts);

or PID-TFD

(for ESCC/QML parts)

Tests vehicle identification/description:

1N5819U01B Lot ID33125201XZ DC1622A	Full Chart F4				
1N5822U01B Lot ID33622004ZW DC1720A	Full Chart F4				

Detail Specification reference:

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock	×	MIL-STD-750 TM2016	1622A 1720A	15 + 15	0	
	Vibration	×	MIL-STD-750 TM2056	1622A 1720A	15 + 15	0	
	Constant acceleration	×	MIL-STD-750 TM2006	1622A 1720A	15 + 15	0	
group	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
al Sub	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
nanic	External Visual	×	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
al/Mecl	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
ment	Temperature Cycling	×	MIL-STD-750 TM1051	1622A 1720A	15 + 15	0	
Environmental/Mechanical Subgroup	Moisture Resistance	×	MIL-STD-750 TM1021	1622A 1720A	15 + 15	0	
	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
	External Visual	☒	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
	Operating Life	☒	ESCC 5000 Para. 8.19	1622A 1720A	15 + 15	0	
Endurance Subgroup	Electrical Measurement	☒	Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
Endu	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
	External Visual Inspection	×	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
1	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
bly up	Terminal Strength	⊠	ESCC 5000 Para. 8.18	1622A 1720A	5 + 5	0	
Assembly Capability Subgroup	Internal Visual	☒	ESCC Basic Spec 20400	1622A 1720A	5 + 5	0	
Sca	Bond Strength	⊠	MIL-STD-750 TM 2037	1622A 1720A	3+3	0	
	Die Shear	⊠	MIL-STD-750 TM 2017	1622A 1720A	3+3	0	



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Appl. No.

Page 4

Executive Member:

CNES

Date: 29/06/2018

302D

18

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Tests conducted in compliance with:

ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts);

or PID-TFD (for ESCC/QML parts)

Tests vehicle identification/description:

1N5819U01B Lot ID33125201XZ DC1622A	Full Chart F4
1N5822U01B Lot ID33622004ZW DC1720A	Full Chart F4

Detail Specification reference:

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock	×	MIL-STD-750 TM2016	1622A 1720A	15 + 15	0	
	Vibration	×	MIL-STD-750 TM2056	1622A 1720A	15 + 15	0	
	Constant acceleration	×	MIL-STD-750 TM2006	1622A 1720A	15 + 15	0	
group	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
al Sub	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
nanic	External Visual	×	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
Environmental/Mechanical Subgroup	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
ment	Temperature Cycling	×	MIL-STD-750 TM1051	1622A 1720A	15 + 15	0	
vironi	Moisture Resistance	×	MIL-STD-750 TM1021	1622A 1720A	15 + 15	0	
En	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
	Electrical Measurement		Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
	External Visual	\boxtimes	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
	Operating Life	\boxtimes	ESCC 5000 Para. 8.19	1622A 1720A	15 + 15	0	
Endurance Subgroup	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	1622A 1720A	15 + 15	0	
Endu	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	1622A 1720A	15 + 15	0	
	External Visual Inspection	×	ESCC Basic Spec 20500	1622A 1720A	15 + 15	0	
	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
up lity	Terminal Strength	×	ESCC 5000 Para. 8.18	1622A 1720A	5 + 5	0	
Assembly Capability Subgroup	Internal Visual	⊠	ESCC Basic Spec 20400	1622A 1720A	5+5	0	
Su	Bond Strength	×	MIL-STD-750 TM 2037	1622A 1720A	3+3	0	
	Die Shear	\boxtimes	MIL-STD-750 TM 2017	1622A 1720A	3+3	0	



Component title:

Switching Diodes based on types 1N5819U and 1N5822U

Page 5 Appl. No.

Executive Member:

CNES

Date: 29/06/2018

302D

Ch art F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
Additional Tests	IVC testing	×	MIL-STD-750 TM1018	1622A 1720A	3+3	0	
Ad							



Component title: Switching Diodes based on types 1N5819U and 1N5822U

Executive Member: CNES Date: 29/06/2018

Page 7
Appl. No.

302D

NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL

ENTRIES Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 22	Additional Comments.